Product Preview **Power MOSFET**

40 V, 240 A, 0.75 m Ω , Single N–Channel

Features

- Typical $R_{DS(on)} = 0.59 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 80 \text{ A}$
- Typical $Q_{g(tot)} = 144 \text{ nC}$ at $V_{GS} = 10 \text{ V}$, $I_D = 80 \text{ A}$
- UIS Capability
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS $T_J = 25^{\circ}C$ unless otherwise noted

Parameter	Symbol	Ratings	Units	
Drain-to-Source Voltage	V _{DSS}	40	V	
Gate-to-Source Voltage	V _{GS}	±20	V	
Drain Current – Continuous (V_{GS} = 10) (Note 1) T_C = 25°C	۱ _D	240	A	
Pulsed Drain Current $T_{C} = 25^{\circ}C$		See Figure 4		
Single Pulse Avalanche Energy (Note 2)	E _{AS}	737	mJ	
Power Dissipation	PD	357	W	
Derate Above 25°C		2.38	W/°C	
Operating and Storage Temperature	T _J , T _{STG}	–55 to +175	°C	
Thermal Resistance, Junction-to-Case	R_{\thetaJC}	0.42 °C/W		
Maximum Thermal Resistance, Junction-to-Ambient (Note 3)	Resistance, Junction-to-CaseR _{0JC} 0.42°C/Wn Thermal Resistance,R _{0JA} 43°C/W			

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Current is limited by bondwire configuration.
- 2. Starting $T_J = 25^{\circ}C$, L = 0.36 mH, $I_{AS} = 64$ A, $V_{DD} = 40$ V during inductor charging and $V_{DD} = 0$ V during time in avalanche.
- 3. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design, while R_{0JA} is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2 oz copper.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

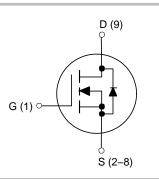


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MO-299A CASE 100CU



ORDERING INFORMATION

Device	Package	Marking
NVBLS0D7N04M8TXG	MO-299A (Pb-Free)	0D7N04M8

Table 1. ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

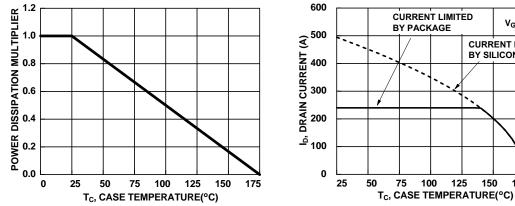
Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
OFF CH/	ARACTERISTICS						
B _{VDSS}	Drain-to-Source Breakdown Voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0 \ V$		40	-	-	V
I _{DSS}	Drain-to-Source Leakage Current	V _{DS} = 40 V, V _{GS} = 0 V	$T_J = 25^{\circ}C$	_	-	1	μΑ
			T _J = 175°C (Note 4)	_	-	1	mA
I _{GSS}	Gate-to-Source Leakage Current	V _{GS} = ±20 V		-	-	±100	nA
ON CHA	RACTERISTICS					-	-
V _{GS(th)}	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		2.0	3.3	4.0	V
R _{DS(on)}	Drain-to-Source On Resistance	I _D = 80 A, V _{GS} = 10 V	$T_J = 25^{\circ}C$	-	0.59	0.75	mΩ
DYNAMI	C CHARACTERISTICS		•				
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		_	12000	-	pF
Coss	Output Capacitance			_	3300	-	pF
C _{rss}	Reverse Transfer Capacitance			_	440	-	pF
Rg	Gate Resistance	f = 1 MHz		_	3.3	-	Ω
Q _{g(ToT)}	Total Gate Charge at 10 V	V _{GS} = 0 to 10 V	V _{DD} = 32 V I _D = 80 A	-	144	188	nC
Q _{g(th)}	Threshold Gate Charge	V _{GS} = 0 to 2 V		_	22	26	nC
Q _{gs}	Gate-to-Source Gate Charge			-	66	-	nC
Q _{gd}	Gate-to-Drain "Miller" Charge			_	16	-	nC
SWITCH	ING CHARACTERISTICS					-	-
t _{on}	Turn–On Time	$V_{DD} = 20 \text{ V, } \text{I}_{D} = 80 \text{ A,}$ $V_{GS} = 10 \text{ V, } \text{R}_{GEN} = 6 \Omega$		_	-	162	ns
t _{d(on)}	Turn–On Delay			_	42	-	ns
t _r	Rise Time			_	73	-	ns
t _{d(off)}	Turn–Off Delay			_	83	-	ns
t _f	Fall Time			_	50	-	ns
t _{off}	Turn–Off Time			_	-	279	ns
DRAIN-S	SOURCE DIODE CHARACTERISTICS	÷		-	-	-	-
V_{SD}	Source-to-Drain Diode Voltage	ode Voltage $I_{SD} = 80 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$		_	-	1.25	V
		I _{SD} = 40 A, V _{GS} = 0 V		_	-	1.2	V
t _{rr}	Reverse–Recovery Time	$I_F = 80 \text{ A}, \text{ dI}_{SD}/\text{d}_t = 100 \text{ A}/\mu\text{s},$ $V_{DD} = 32 \text{ V}$		_	111	129	ns
Q _{rr}	Reverse–Recovery Charge			_	178	214	nC

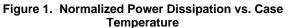
Qrr

Reverse-Recovery Charge

4. The maximum value is specified by design at T_J = 175°C. Product is not tested to this condition in production. Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Typical Characteristics







100

125

150

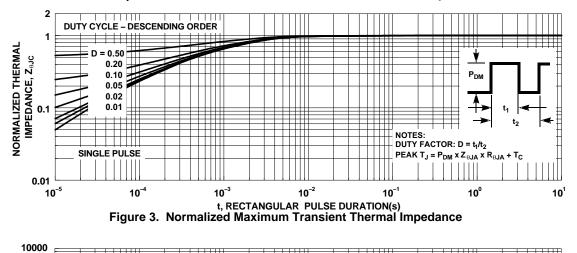
175

200

75

V_{GS} = 10V

CURRENT LIMITED BY SILICON



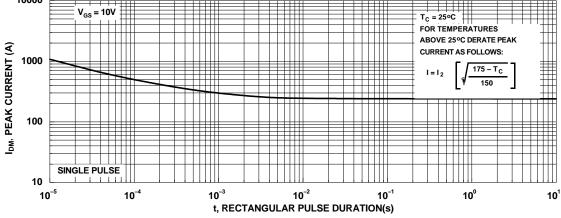


Figure 4. Peak Current Capability

Typical Characteristics

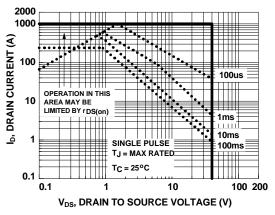
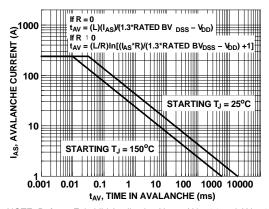
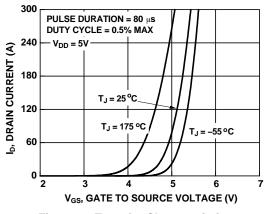


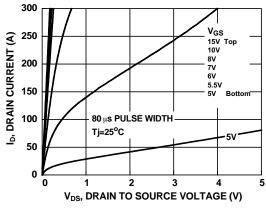
Figure 5. Forward Bias Safe Operating Area



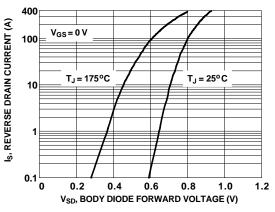
NOTE: Refer to Fairchild Application Notes AN7514 and AN7515 Figure 6. Unclamped Inductive Switching Capability



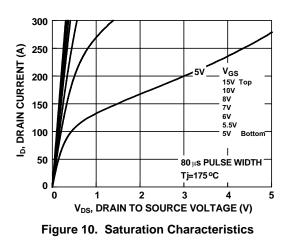




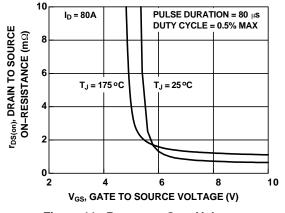




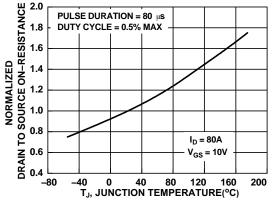




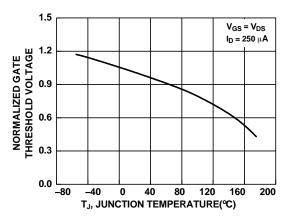
Typical Characteristics

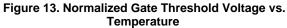












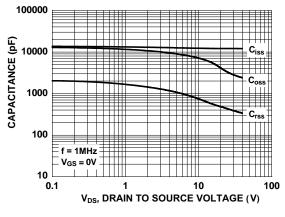
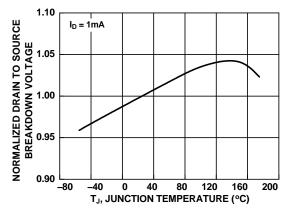
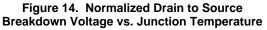
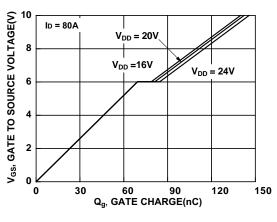
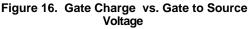


Figure 15. Capacitance vs. Drain to Source Voltage

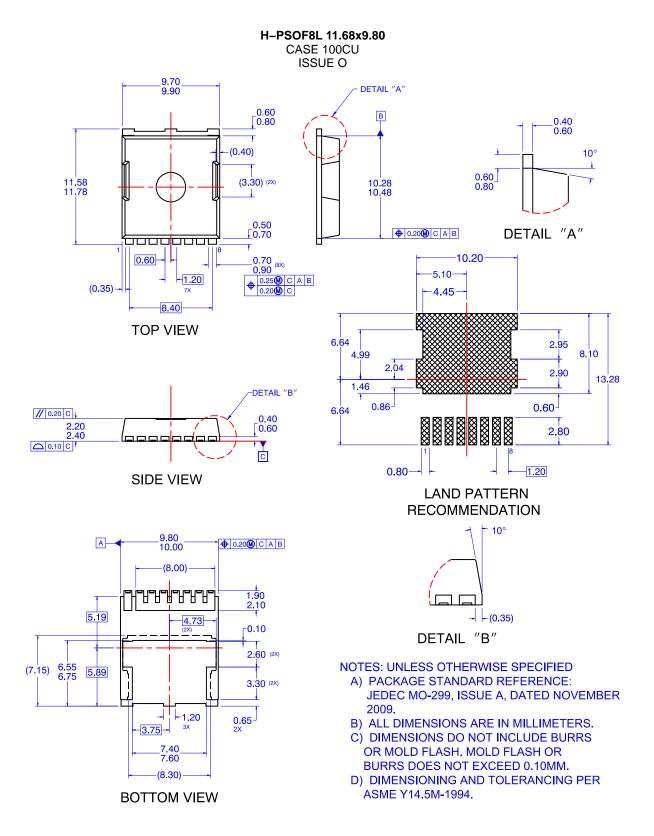








PACKAGE DIMENSIONS



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